

**What is claimed is:**

- 1. A magnetic disk apparatus including:**  
a read gate generation unit which generates  
5 a read gate signal having a predefined read start  
time and read end time that are set using a sector  
pulse as a reference; and  
a data demodulation unit which reproduces  
read data from a medium readout signal by  
10 executing a read based on the read gate signal,  
the magnetic disk apparatus comprising:  
a read gate optimization unit which detects  
errors of read data demodulated by the data  
demodulation unit while varying the read start  
15 time and the read end time of the read gate signal,  
the read gate optimization unit determining the  
read start time and the read end time at which the  
detected errors are minimized and setting the  
determined read start and end times in the read  
20 gate generation unit.
- 2. The magnetic disk apparatus according to**  
**claim 1, wherein**  
the read gate optimization unit includes:  
25 a timing adjustment unit which varies the  
read start time and the read end time of the read  
gate signal for output to the data demodulation

unit, for each of plural times of executions of test read;

an error detection unit which detects errors of the read data demodulated by the data

5 demodulation unit, for each execution of test read, based on the read gate signal output from the timing adjustment unit; and

an optimum time determination unit which determines as optimum times the read start time 10 and the read end time of the read gate signal at which the errors are minimized of a plurality of errors detected by the error detection unit, the optimum time determination unit setting the determined optimum times in the read gate 15 generation unit.

3. The magnetic disk apparatus according to claim 2, wherein

the timing adjustment unit varies the read 20 start time and the read end time of the read gate signal individually, and wherein

the optimum time determination unit 25 individually determines the read start time and the read end time at which the errors detected by the error detection unit are minimized, for setting in the read gate generation unit.

4. The magnetic disk apparatus according to  
claim 2, wherein

the timing adjustment unit varies the read  
start time and the read end time backward and  
5 forward around a default value in a predefined  
time unit.

5. The magnetic disk apparatus according to  
claim 2, wherein

10 the timing adjustment unit varies the read  
start time and the read end time backward and  
forward around a default value in a read data one  
byte time unit.

15 6. The magnetic disk apparatus according to  
claim 2, wherein

the error detection unit detects as the read  
data errors Viterbi metric margins of a Viterbi  
determination unit disposed in the data  
20 demodulation unit, and wherein  
the optimum time determination unit  
determines the read start time and the read end  
time at which the detected Viterbi metric margins  
are maximized, for setting in the read gate  
25 generation unit.

7. The magnetic disk apparatus according to

claim 1, wherein

the error detection unit detects an error rate of the read data demodulated by the data demodulation unit, and wherein

5       the optimum time determination unit determines the read start time and the read end time at which the detected error rate is minimized, for setting in the read gate generation unit.

10    8.   The magnetic disk apparatus according to claim 1, wherein

the read gate optimization unit is operated at the time of power-on start.

15    9.   The magnetic disk apparatus according to claim 1, wherein

the read gate optimization unit is operated in accordance with a predefined time schedule.

20    10.   The magnetic disk apparatus according to claim 1, wherein

the read gate optimization unit is operated when a change is detected in environmental conditions such as a temperature inside the 25 apparatus.

11.   The magnetic disk apparatus according to

claim 1, wherein

when a plurality of readout heads are disposed, the read gate optimization unit is operated on a head-to-head basis.

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12. The magnetic disk apparatus according to claim 1, wherein

when the medium is divided into zones, the read gate optimization unit is operated on a 10 zone-to-zone basis.

13. A read gate optimization method for a magnetic disk apparatus including a read gate generation unit which generates a read gate signal 15 having a predefined read start time and read end time that are set using a sector pulse as a reference, and a data demodulation unit which reproduces read data from a medium readout signal by executing a read based on the read gate signal, 20 the method comprising:

a timing adjustment step varying the read start time and the read end time of the read gate signal for output to the data demodulation unit, for each of plural times of executions of test 25 read;

an error detection step detecting errors of the read data and modulated in the data demodulation

unit, for each execution of test read, based on the read gate signal output in the timing adjustment step; and

an optimum time determination step

5 determining as optimum times the read start time and the read end time of the read gate signal at which the errors are minimized of a plurality of errors detected in the error detection step, and setting the determined optimum times in the read

10 gate generation unit.

14. The read gate optimization method for a magnetic disk apparatus according to claim 13, wherein

15 the timing adjustment step includes varying individually the read start time and the read end time of the read gate signal.

16. The read gate optimization method for a magnetic disk apparatus according to claim 13, wherein

the timing adjustment step includes varying the read start time and the read end time backward and forward around a default value in a predefined 25 time unit.

17. The read gate optimization method for a

magnetic disk apparatus according to claim 13,  
wherein

5       the timing adjustment step includes varying  
the read start time and the read end time backward  
and forward around a default value in a read data  
one byte time unit, for detection of errors.

17. The read gate optimization method for a  
magnetic disk apparatus according to claim 13,  
10    wherein

the error detection step includes detecting  
as the read data errors Viterbi metric margins of  
a Viterbi determination unit disposed in the data  
demodulation unit, and wherein

15       the optimum time determination step  
includes determining the read start time and the  
read end time at which the detected Viterbi metric  
margins are maximized, and setting the determined  
times in the read gate generation unit.

20  
18. The read gate optimization method for a  
magnetic disk apparatus according to claim 13,  
wherein

25       the error detection step includes detecting  
an error rate of the read data demodulated by the  
data demodulation unit, and wherein  
the optimum time determination step

includes determining the read start time and the read end time at which the detected error rate is minimized are determined, and setting the determined times in the read gate generation unit.

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19. A program operable to cause a computer to execute:

the computer being incorporated in a magnetic disk apparatus including a read gate 10 generation unit which generates a read gate signal having a predefined read start time and read end time that are set using a sector pulse as a reference, and a data demodulation unit which reproduces read data from a medium readout signal 15 by executing a read based on the read gate signal, a timing adjustment step varying the read start time and the read end time of the read gate signal for output to the data demodulation unit, for each of plural times of executions of test 20 read;

an error detection step detecting errors of the read data demodulated in the data demodulation unit, for each execution of test read, based on the read gate signal output in the timing 25 adjustment step; and

an optimum time determination step determining as optimum times the read start time

and the read end time of the read gate signal at which the errors are minimized of a plurality of errors detected in the error detection step, and setting the determined optimum times in the read gate generation unit.